



### FEATURES

75.5 dBFS SNR to 170 MHz at 250 MSPS @ 2.5 V p-p FS 74 dBFS SNR to 170 MHz at 250 MSPS @ 2.0 V p-p FS 90 dBFS SFDR to 300 MHz at 250 MSPS (@ -1 dBFS) at 2.5 V p-p FS 95 dBFS SFDR to 170 MHz at 250 MSPS (@ -1 dBFS) at 2.0 V p-p FS 100 dBFS SFDR at 100 MHz at 160 MSPS (@ -1 dBFS) 60 fs rms Jitter **Excellent linearity**  $DNL = \pm 1.0 LSB typical$ INL = ±3.0 LSB typical 2 V p-p to 2.5 V p-p (default) differential full-scale input (programmable) Integrated input buffer **External reference support option Clock duty cycle stabilizer** Output clock available Serial port control Built-in selectable digital test pattern generation Selectable output data format LVDS outputs (ANSI-644 compatible) 1.8 V and 3.3 V supply operation

#### **APPLICATIONS**

Multicarrier, multimode cellular receivers Antenna array positioning Power amplifier linearization Broadband wireless Radar Infrared imaging Communications instrumentation

#### **GENERAL DESCRIPTION**

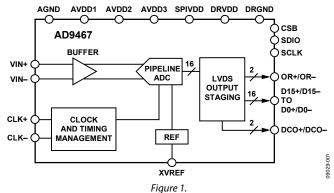
The AD9467 is a 16-bit, monolithic, IF sampling analog-todigital converter (ADC). It is optimized for high performance over wide bandwidths and ease of use. The product operates at a 250 MSPS conversion rate and is designed for wireless receivers, instrumentation, and test equipment that require a high dynamic range.

The ADC requires 1.8 V and 3.3 V power supplies and a low voltage differential input clock for full performance operation. No external reference or driver components are required for

## 16-Bit, 200 MSPS/250 MSPS Analog-to-Digital Converter

## AD9467

#### FUNCTIONAL BLOCK DIAGRAM



many applications. Data outputs are LVDS compatible (ANSI-644 compatible) and include the means to reduce the overall current needed for short trace distances.

A data clock output (DCO) for capturing data on the output is provided for signaling a new output bit.

The internal power-down feature supported via the SPI and typically consumes less than 5 mW when disabled.

Optional features allow users to implement various selectable operating conditions, including input range, data format select, and output data test patterns.

The AD9467 is available in a Pb-free, 72-lead, LFCSP specified over the  $-40^{\circ}$ C to  $+85^{\circ}$ C industrial temperature range.

### **PRODUCT HIGHLIGHTS**

- 1. IF optimization capability used to improve SFDR.
- 2. Outstanding SFDR performance for IF sampling applications such as multicarrier, multimode 3G, and 4G cellular base station receivers.
- 3. Ease of use: on-chip reference, high input impedance buffer, adjustable analog input range, and an output clock to simplify data capture.
- 4. Packaged in a Pb-free, 72-lead LFCSP package.
- 5. Clock duty cycle stabilizer (DCS) maintains overall ADC performance over a wide range of input clock pulse widths.
- 6. Standard serial port interface (SPI) supports various product features and functions, such as data formatting (offset binary, twos complement, or Gray coding), enabling the clock DCS.

Rev. PrB

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### **SPECIFICATIONS**

AVDD1 = 1.8 V, AVDD2 = 3.3 V, AVDD3 = 1.8 V, DRVDD = 1.8 V, specified maximum sampling rate, 2.5 V p-p differential input, 1.25 V internal reference, AIN = -1.0 dBFS, DCS on, default SPI settings, unless otherwise noted.

Table 1.

		ADS	9467BCP	Z-200	AD9	9467BCP	Z-250	
Parameter <sup>1</sup>	Temp	Min	Тур	Max	Min	Тур	Max	Unit
RESOLUTION		16			16			Bits
ACCURACY								
No Missing Codes	Full		Guarante	ed		Guarante	ed	
Offset Error	Full		±1			±1		LSB
Gain Error	Full		±3			±3		%FSR
Differential Nonlinearity (DNL)	Full		±1			±1		LSB
Integral Nonlinearity (INL)	Full		±3			±3		LSB
TEMPERATURE DRIFT								
Offset Error	Full		TBD			TBD		ppm/°0
Gain Error	Full		TBD			TBD		ppm/°0
ANALOG INPUTS								
Differential Input Voltage Range (Internal VREF = 1 V to 1.25 V)	Full	2	2.5	2.5	2	2.5	2.5	V p-p
Common-Mode Voltage	Full		2.25			2.1		V
Differential Input Resistance	Full		530			530		Ω
Differential Input Capacitance	Full		3.5			3.5		рF
Analog Bandwidth	25°C		900			900		MHz
XVREF INPUT								
Input Voltage	Full	1		1.25	1		1.25	V
Input Capacitance	Full		3			3		pF
POWER SUPPLY								
AVDD1	Full	1.75	1.8	1.85	1.75	1.8	1.85	V
AVDD2	Full	3.0	3.3	3.6	3.0	3.3	3.6	V
AVDD3	Full	1.7	1.8	1.9	1.7	1.8	1.9	V
DRVDD	Full	1.7	1.8	1.9	1.7	1.8	1.9	V
I <sub>AVD1</sub>	Full		520			560		mA
I <sub>AVDD2</sub>	Full		50			50		mA
I <sub>AVDD3</sub>	Full		30			30		mA
ldrvdd	Full		45			45		mA
Total Power Dissipation (Including Output Drivers)	Full		1.24			1.32		W
Power-Down Dissipation	Full	1	5			5		mW

<sup>1</sup> See the AN-835 Application Note, Understanding High Speed ADC Testing and Evaluation, for a complete set of definitions and how these tests were completed.

### AC SPECIFICATIONS

AVDD1 = 1.8 V, AVDD2 = 3.3 V, AVDD3 = 1.8 V, DRVDD = 1.8 V, specified maximum sampling rate, 2.5 V p-p differential input, 1.25 V internal reference, AIN = -1.0 dBFS, DCS on, default SPI settings, unless otherwise noted.

#### Table 2.

	AD9467BCPZ-200				Α	AD9467BCPZ-250		
Parameter <sup>1</sup>	Temp	Min	Тур	Max	Min	Тур	Max	Unit
ANALOG INPUT FULL SCALE			2/2.5			2/2.5		V p-p
SIGNAL-TO-NOISE RATIO (SNR)								
$f_{IN} = 5 MHz$	Full		74.7/76.4			74.7/76.4		dBFS
$f_{IN} = 97 \text{ MHz}$	Full		74.5/76.1			74.5/76.1		dBFS
$f_{IN} = 140 \text{ MHz}$	Full		74.5/75.8			74.5/75.8		dBFS
$f_{IN} = 170 \text{ MHz}$	Full		74.3/75.6			74.3/75.6		dBFS
$f_{IN} = 210 \text{ MHz}$	Full		74/75.1			74/75.1		dBFS
f <sub>IN</sub> = 300 MHz	Full		73.3/74.4			73.3/74.4		dBFS
SIGNAL-TO-NOISE AND DISTORTION RATIO (SINAD)								
$f_{IN} = 5 MHz$	Full		74.6/76.3			74.6/76.3		dBFS
$f_{IN} = 97 \text{ MHz}$	Full		74.4/76			74.4/76		dBFS
$f_{IN} = 140 \text{ MHz}$	Full		74.3/75.6			74.3/75.6		dBFS
$f_{IN} = 170 \text{ MHz}$	Full		74.1/75.4			74.1/75.4		dBFS
$f_{IN} = 210 \text{ MHz}$	Full		73.7/74.8			73.7/74.8		dBFS
f <sub>IN</sub> = 300 MHz	Full		73/74.1			73/74.1		dBFS
EFFECTIVE NUMBER OF BITS (ENOB)								
$f_{IN} = 5 MHz$	Full		12.1/12.4			12.1/12.4		Bits
$f_{IN} = 97 \text{ MHz}$	Full		12.1/12.3			12.1/12.3		Bits
$f_{IN} = 140 \text{ MHz}$	Full		12/12.2			12/12.2		Bits
$f_{IN} = 170 \text{ MHz}$	Full		12/12.2			12/12.2		Bits
$f_{IN} = 210 \text{ MHz}$	Full		11.9/12.1			11.9/12.1		Bits
f <sub>IN</sub> = 300 MHz	Full		11.8/12			11.8/12		Bits
SPURIOUS-FREE DYNAMIC RANGE (SFDR), 2 <sup>nd</sup> or 3 <sup>rd</sup> HD								
$f_{IN} = 5 MHz$	Full		98/95			98/95		dBFS
f <sub>IN</sub> = 97 MHz	Full		96/92			96/92		dBFS
$f_{IN} = 140 \text{ MHz}$	Full		96/91			96/91		dBFS
$f_{IN} = 170 \text{ MHz}$	Full		95/90			95/90		dBFS
$f_{IN} = 210 \text{ MHz}$	Full		92/90			92/90		dBFS
f <sub>IN</sub> = 300 MHz	Full		92/90			92/90		dBFS
WORST OTHER (Excluding Second or Third)								
$f_{IN} = 5 MHz$	Full		98/98			98/98		dBFS
$f_{IN} = 97 \text{ MHz}$	Full		97/97			97/97		dBFS
$f_{IN} = 140 \text{ MHz}$	Full		97/97			97/97		dBFS
$f_{IN} = 170 \text{ MHz}$	Full		97/97			97/97		dBFS
$f_{IN} = 210 \text{ MHz}$	Full		97/97			97/97		dBFS
$f_{IN} = 300 \text{ MHz}$	Full		97/97			97/97		dBFS
TWO-TONE INTERMODULATION DISTORTION (IMD)— AIN1 AND AIN2 = -7.0 dBFS								
$f_{IN1} = 97 \text{ MHz}, f_{IN2} = 98 \text{ MHz}$	25°C		TBD/TBD			TBD/TBD		dBc
f <sub>IN1</sub> = 171 MHz, f <sub>IN2</sub> = 170 MHz	25°C		TBD/TBD			TBD/TBD		dBc

<sup>1</sup> See the AN-835 Application Note, Understanding High Speed ADC Testing and Evaluation, for a complete set of definitions and how these tests were completed.

### **DIGITAL SPECIFICATIONS**

AVDD1 = 1.8 V, AVDD2 = 3.3 V, AVDD3 = 1.8 V, DRVDD = 1.8 V, specified maximum sampling rate, 2.5 V p-p differential input, 1.25 V internal reference, AIN = -1.0 dBFS, DCS on, default SPI settings, unless otherwise noted.

#### Table 3.

			AD9467	BCPZ-200		AD9467	BCPZ-250	
Parameter <sup>1</sup>	Temp	Min	Тур	Max	Min	Тур	Max	Unit
CLOCK INPUTS (CLK+, CLK-)								
Logic Compliance			CMOS/LVI	DS/LVPECL		CMOS/LV	DS/LVPECL	
Differential Input Voltage <sup>2</sup>	Full	250			250			mV p-p
Input Common-Mode Voltage	Full		0.8			0.8		V
Input Resistance (Differential)	25°C		20			20		kΩ
Input Capacitance	25°C		2.5			2.5		pF
LOGIC INPUTS (SCLK, CSB, SDIO)								
Logic 1 Voltage	Full	1.2		3.6	1.2		3.6	V
Logic 0 Voltage	Full			0.3			0.3	V
Input Resistance	25°C		30			30		kΩ
Input Capacitance	25°C		0.5			0.5		pF
LOGIC OUTPUT (SDIO) <sup>3</sup>								
Logic 1 Voltage ( $I_{OH} = 800 \ \mu A$ )	Full		1.7/3.1			1.7/3.1		V
Logic 0 Voltage ( $I_{OL} = 50 \mu A$ )	Full			0.3			0.3	V
DIGITAL OUTPUTS (D0+ to D15+, D0- to D15-, DCO, OR+, OR-)								
Logic Compliance		LVDS	LVDS	5				
Differential Output Voltage (Vod)	Full	247		545	247		545	mV
Output Offset Voltage (Vos)	Full	1.125		1.375	1.12	5	1.375	V
Output Coding (Default)			Offset	binary		Offset	binary	

<sup>1</sup> See the AN-835 Application Note, *Understanding High Speed ADC Testing and Evaluation*, for a complete set of definitions and how these tests were completed. <sup>2</sup> This is specified for LVDS and LVPECL only. <sup>3</sup> This depends on if SPIVDD is tied to a 1.8 V or 3.3 V supply.

### SWITCHING SPECIFICATIONS

AVDD1 = 1.8 V, AVDD2 = 3.3 V, AVDD3 = 1.8 V, DRVDD = 1.8 V, specified maximum sampling rate, 2.5 V p-p differential input, 1.25 V internal reference, AIN = -1.0 dBFS, DCS on, default SPI settings, unless otherwise noted.

#### Table 4.

		Α	D9467BCP	Z-200	Α	D9467BCP	Z-250		
Parameter <sup>1</sup>	Temp	Min	Тур	Max	Min	Тур	Max	Unit	
CLOCK <sup>2</sup>									
Maximum Clock Rate	Full	200			250			MSPS	
Minimum Clock Rate	Full			10			10	MSPS	
Clock Pulse Width High (t <sub>CH</sub> )	Full		2.4			2		ns	
Clock Pulse Width Low (t <sub>CL</sub> )	Full		2.4			2		ns	
OUTPUT PARAMETERS <sup>2, 3</sup>									
Propagation Delay (t <sub>PD</sub> )	Full		2.8			2.8		ns	
Rise Time (t <sub>R</sub> ) (20% to 80%)	Full		300			300		ps	
Fall Time (t <sub>F</sub> ) (20% to 80%)	Full		300			300		ps	
DCO Propagation Delay (tcpd)	Full		3			3		ns	
DCO to Data Delay (tskew)	Full	700	-200	300	700	-200	300	ps	
Wake-Up Time (Power-Down)	Full		100			100		ms	
Pipeline Latency	Full		16			16		Clock cycles	
APERTURE									
Aperture Delay (t <sub>A</sub> )	25°C		1.2			1.2		ns	
Aperture Uncertainty (Jitter)	25°C		60			60		fs rms	
Out-of-Range Recovery Time	25°C		1			1		Clock cycles	

<sup>1</sup> See the AN-835 Application Note, Understanding High Speed ADC Testing and Evaluation, for a complete set of definitions and how these tests were completed. <sup>2</sup> Can be adjusted via the SPI interface.

<sup>3</sup> Measurements were made using a part soldered to FR-4 material.

#### **Timing Diagrams**

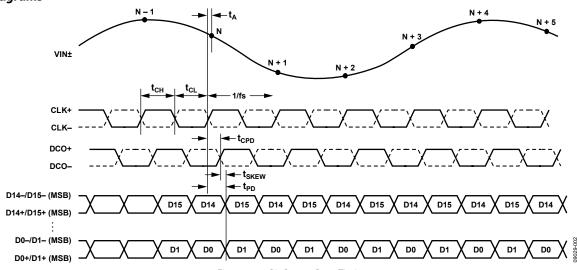


Figure 2. 16-Bit Output Data Timing

### **ABSOLUTE MAXIMUM RATINGS**

### Table 5.

Parameter	With Respect To	Rating
Electrical	•	
AVDD1, AVDD3	AGND	–0.3 V to +2.0 V
AVDD2, SPIVDD	AGND	–0.3 V to +3.9 V
DRVDD	DRGND	–0.3 V to +2.0 V
AGND	DRGND	–0.3 V to +0.3 V
AVDD2, SPIVDD	AVDD1, AVDD3	–2.0 V to +3.9 V
AVDD1, AVDD3	DRVDD	–2.0 V to +2.0 V
AVDD2, SPIVDD	DRVDD	–2.0 V to +3.9 V
Digital Outputs (Dx+, Dx-, OR+, OR-, DCO+, DCO-)	DRGND	–0.3 V to DRVDD+0.2 V
CLK+, CLK–	AGND	–0.3 V to AVDD1+0.2 V
VIN+, VIN–	AGND	–0.3 V to AVDD2+0.3 V
XVREF	AGND	–0.3 V to AVDD1+0.2 V
SCLK, CSB, SDIO	AGND	–0.3 V to SPIVDD+0.2 V
Environmental		
Operating Temperature Range (Ambient)		–40°C to +85°C
Maximum Junction Temperature		150°C
Lead Temperature (Soldering, 10 sec)		300°C
Storage Temperature Range (Ambient)		–65°C to +150°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### **THERMAL IMPEDANCE**

#### Table 6.

1 4010 01				
Air Flow Velocity (m/sec)	<b>θ</b> <sub>JA</sub> <sup>1, 2</sup>	<b>θ</b> <sub>JB</sub> <sup>1, 3, 4</sup>	<b>θ</b> <sub>JC</sub> <sup>1, 5</sup>	Unit
0.0	15.7°C/W	7.5°C/W	0.5°	°C/W
1.0	13.7°C/W	N/A	N/A	°C/W
2.5	12.3°C/W	N/A	N/A	°C/W

<sup>1</sup> Per JEDEC 51-7, plus JEDEC 51-5 2S2P test board.

<sup>2</sup> Per JEDEC JESD51-2 (still air) or JEDEC JESD51-6 (moving air).

<sup>3</sup> Per JEDEC JESD51-8 (still air).

 $^{4}$  N/A = not applicable.

<sup>5</sup> Per MIL-STD 883, Method 1012.1.

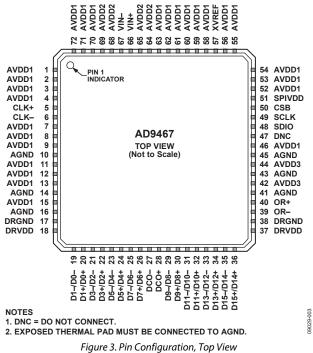
#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

### **Preliminary Technical Data**

### **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**

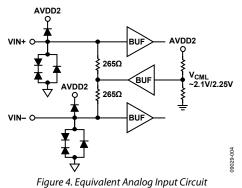


**Table 7. Pin Function Descriptions** 

Pin No.	Mnemonic	Description
0	EPAD	Exposed Paddle. The exposed paddle must be connected to AGND.
10, 14, 16, 41, 43, 45	AGND	Analog Ground.
1, 2, 3, 4, 7, 8, 9, 11, 12, 13, 15, 46, 52, 53, 54, 55, 56, 58, 59, 60, 61, 62, 63, 70, 71, 72	AVDD1	1.8 V Analog Supply.
64, 65, 68, 69	AVDD2	3.3 V Analog Supply.
42, 44	AVDD3	1.8 V Analog Supply.
51	SPIVDD	1.8 V or 3.3 V SPI Supply
17, 38	DRGND	Digital Output Driver Ground.
18, 37	DRVDD	1.8 V Digital Output Driver Supply.
67	VIN-	Analog Input Complement.
66	VIN+	Analog Input True.
6	CLK–	Clock Input Complement.
5	CLK+	Clock Input True.
19	D0-/D1-	D0 (LSB) and D1 Digital Output Complement.
20	D0+/D1+	D0 (LSB) and D1 True Digital Output True.
21	D2-/D3-	D2 and D3 Digital Output Complement.
22	D2+/D3+	D2 and D3 True Digital Output True.
23	D4-/D5-	D4 and D5 Digital Output Complement.
24	D4+/D5+	D4 and D5 True Digital Output True.
25	D6-/D7-	D6 and D7 Digital Output Complement.
26	D6+/D7+	D6 and D7 True Digital Output True.
29	D8-/D9-	D8 and D9 Digital Output Complement.
30	D8+/D9+	D8 and D9 True Digital Output True.
31	D10-/D11-	D10 and D11 Digital Output Complement.
32	D10+/D11+	D10 and D11 True Digital Output True.
33	D12–/D13–	D12 and D13 Digital Output Complement.
34	D12+/D13+	D12 and D13 True Digital Output True.
35	D14–/D15–	D14 and D15 (MSB) Digital Output Complement.

Pin No.	Mnemonic	Description	
36	D14+/D15+	D14 and D15 (MSB) True Digital Output True.	
27	DCO-	Data Clock Digital Output Complement.	
28	DCO+	Data Clock Digital Output True.	
39	OR-	Out-of-Range Digital Output Complement.	
40	OR+	Out-of-Range Digital Output True.	
47	DNC	Do Not Connect (Leave Pin Floating).	
48	SDIO	Serial Data Input/Output.	
49	SCLK	Serial Clock.	
50	CSB	Chip Select Bar.	
57	XVREF	External VREF Option.	

### **EQUIVALENT CIRCUITS**



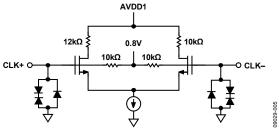


Figure 5. Equivalent Clock Input Circuit

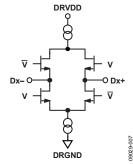


Figure 6. Equivalent Digital Output Circuit

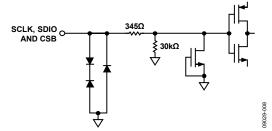


Figure 7. Equivalent SCLK, SDIO, and CSB Input Circuit

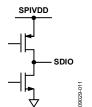
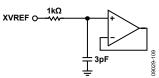


Figure 8. Equivalent SDIO Output Circuit



*Figure 9. Equivalent External VREF Input Circuit (When Enabled)* 

### THEORY OF OPERATION

The AD9467 architecture consists of an input-buffered pipelined ADC that consists of a 3-bit first stage, a 4-bit second stage, followed by four 3-bit stages and a final 3-bit flash. Each stage provides sufficient overlap to correct for flash errors in the preceding stage.

The input buffer provides a linear high input impedance (for ease of drive) and isolates the ADC driver from any kick-back due to the sample and hold operation. The buffer is optimized for high linearity, low noise, and low power. The quantized outputs from each stage are combined into a final 16-bit result in the digital correction logic. The pipelined architecture permits the first stage to operate with a new input sample while the remaining stages operate with preceding samples. Sampling occurs on the rising edge of the clock.

Each stage of the pipeline, excluding the last, consists of a low resolution flash ADC connected to a switched-capacitor DAC and an interstage residue amplifier (for example, a multiplying digital-to-analog converter (MDAC)). The residue amplifier magnifies the difference between the reconstructed DAC output and the flash input for the next stage in the pipeline. One bit of redundancy is used in each stage to facilitate digital correction of flash errors. The last stage simply consists of a flash ADC.

The output staging block aligns the data, corrects errors, and passes the data to the output buffers.

### ANALOG INPUT CONSIDERATIONS

The analog input to the AD9467 is a differential buffer. For best dynamic performance, the source impedances driving VIN+ and VIN– should be matched such that common-mode settling errors are symmetrical. The analog input is optimized to provide superior wideband performance and requires that the analog inputs be driven differentially. SNR and SINAD performance degrades significantly if the analog input is driven with a single-ended signal.

In either case, a small resistor in series with each input can help reduce the peak transient current injected from the output stage of the driving source. In addition, low Q inductors or ferrite beads can be placed on each leg of the input to reduce high differential capacitance at the analog inputs and therefore achieve the maximum bandwidth of the ADC. Such use of low Q inductors or ferrite beads is required when driving the converter front end at high IF frequencies. Either a shunt capacitor or two single-ended capacitors can be placed on the inputs to provide a matching passive network. This ultimately creates a low-pass filter at the input to limit unwanted broadband noise. See the AN-742 Application Note, the AN-827 Application Note, and the *Analog Dialogue* article "Transformer-Coupled Front-End for Wideband A/D Converters" (Volume 39, April 2005) for more information. In general, the precise values depend on the application.

For best dynamic performance, the source impedances driving VIN+ and VIN- should be matched such that common-mode settling errors are symmetrical. These errors are reduced by the common-mode rejection of the ADC. An internal reference buffer creates the positive and negative reference voltages, REFT and REFB, respectively, that define the span of the ADC core.

Maximum SNR performance is achieved by setting the ADC to the largest span in a differential configuration. In the case of the AD9467, the largest input span available is 2.5 V p-p.

#### **Differential Input Configurations**

There are several ways to drive the AD9467 either actively or passively; however, optimum performance is achieved by driving the analog input differentially.

For applications where SNR and SFDR are key parameters, differential transformer coupling is the recommended input configuration (see Figure 10 and Figure 11), because the noise performance of most amplifiers is not adequate to achieve the true performance of the AD9467.

Regardless of the configuration, the value of the shunt capacitor, C, is dependent on the input frequency and may need to be reduced or removed.

Using the ADL5562 differential driver to drive the AD9467 provides excellent, flexible gain option to interface to the ADC (see Figure 13) for both baseband and high IF applications. Using an amplifier also provides better isolation from the preceding stages as well as better pass-band flatness.

When using any amplifier, the user has the option to disconnect the input common-mode voltage buffer from the analog inputs. This allows the common-mode output pin of the amplifier to set this voltage between the interface of the two devices. See the Memory Map section for more details.

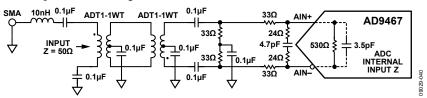


Figure 10. Differential Transformer-Coupled Configuration for Baseband Applications up to 150 MHz

### **Preliminary Technical Data**

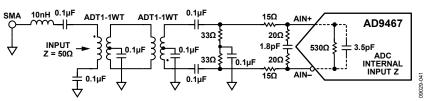


Figure 11. Differential Transformer-Coupled Configuration for IF Applications from 150 to 300 MHz

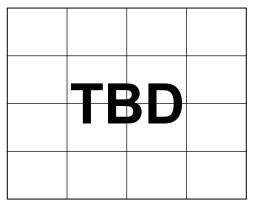


Figure 12. Differential Transformer-Coupled Configuration for IF Applications up to 300 MHz

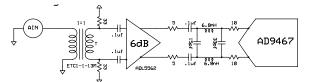


Figure 13. Differential Input Configuration Using the ADL5562

### **CLOCK INPUT CONSIDERATIONS**

For optimum performance, the AD9467 sample clock inputs (CLK+ and CLK–) should be clocked with a differential signal. This signal is typically ac-coupled to the CLK+ and CLK– pins via a transformer or capacitors. These pins are biased internally and require no additional biasing.

Figure 14 shows a preferred method for clocking the AD9467. The low jitter clock source is converted from a single-ended signal to a differential signal using an RF transformer. The back-toback Schottky diodes across the secondary transformer limit clock excursions into the AD9467 to approximately 0.8 V p-p differential. This helps prevent the large voltage swings of the clock from feeding through to other portions of the AD9467, and it preserves the fast rise and fall times of the signal, which are critical to low jitter performance.

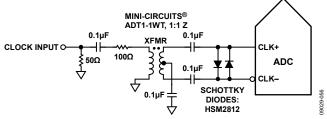


Figure 14. Transformer-Coupled Differential Clock

Another option is to ac-couple a differential PECL or LVDS signal to the sample clock input pins, as shown in Figure 15 and Figure 16. The AD9510/AD9511/AD9512/AD9513/AD9514/ AD9515/AD9516/AD9517/AD9520/AD9522 family of clock drivers offers excellent jitter performance.

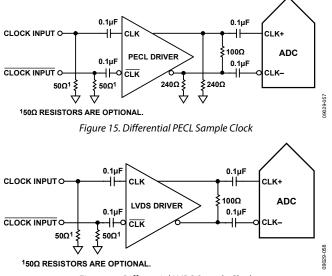


Figure 16. Differential LVDS Sample Clock

#### **Clock Duty Cycle Considerations**

Typical high speed ADCs use both clock edges to generate a variety of internal timing signals. As a result, these ADCs may be sensitive to clock duty cycle. Commonly, a 5% tolerance is required on the clock duty cycle to maintain dynamic performance characteristics. The AD9467 contains a duty cycle stabilizer (DCS) that retimes the nonsampling edge, providing an internal clock signal with a nominal 50% duty cycle. This allows a wide range of clock input duty cycles without affecting the performance of the AD9467. When the DCS is on, noise and distortion performance are nearly flat for a wide range of duty cycles. However, some applications may require the DCS function to be off. If so, keep in mind that the dynamic range performance can be affected when operated in this mode. See the Memory Map section for more details on using this feature.

The AD9467 contains a duty cycle stabilizer (DCS) that retimes the nonsampling, or falling edge, providing an internal clock signal with a nominal 50% duty cycle. This allows a wide range of clock input duty cycles without affecting the performance. Noise and distortion performance are nearly flat for a wide range of duty cycles when the DCS is on,

Any changes to the sampling frequency require several clock cycles to allow the internal timing to acquire and lock at the new sampling rate.

### **Clock Jitter Considerations**

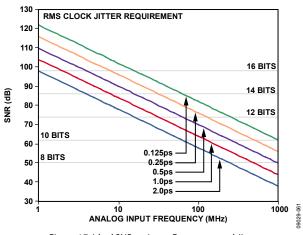
High speed, high resolution ADCs are sensitive to the quality of the clock input. The degradation in SNR at a given input frequency  $(f_A)$  due only to aperture jitter  $(t_J)$  can be calculated by

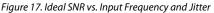
$$SNR = 20 \times \log 10(2 \times \pi \times f_A \times t_J)$$

In this equation, the rms aperture jitter represents the root mean square of all jitter sources, including the clock input, analog input signal, and ADC aperture jitter specifications. IF undersampling applications are particularly sensitive to jitter (see Figure 17).

The clock input should be treated as an analog signal in cases where aperture jitter may affect the dynamic range of the AD9467. Power supplies for clock drivers should be separated from the ADC output driver supplies to avoid modulating the clock signal with digital noise. Low jitter, crystal-controlled oscillators make the best clock sources. If the clock is generated from another type of source (by gating, dividing, or other methods), it should be retimed by the original clock at the last step.

Refer to the AN-501 Application Note and the AN-756 Application Note for more in-depth information about jitter performance as it relates to ADCs.





### Power Dissipation and Power-Down Mode

As shown in Figure 18, the power dissipated by the AD9467 is proportional to its sample rate. The digital power dissipation does not vary much because it is determined primarily by the DRVDD supply and bias current of the LVDS output drivers.

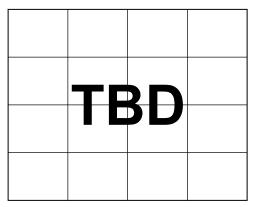
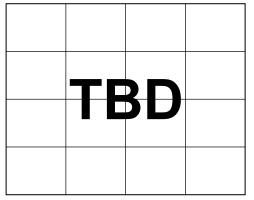


Figure 18. Supply Current vs.  $f_{SAMPLE}$  for  $f_{IN} = 5$  MHz, AD9467-200





By asserting the power-down option via the SPI register map (0x08[1:0]), the AD9467 is placed into power-down mode. In this state, the ADC typically dissipates 5 mW. During power-down, the LVDS output drivers are placed in a high impedance state.

In power-down mode, low power dissipation is achieved by shutting down the internal reference, reference buffer, digital output, and biasing networks. The device requires approximately 100 ms to restore full operation.

See the Memory Map section for more details on using these features.

#### **Power Supplies**

To achieve the best dynamic performance of the AD9467, it is recommended that each power supply pin be decoupled as closely to the package as possible with 0.1  $\mu$ F, X7R or X5R type decoupling capacitors. For optimum performance, all supplies should be at typical values or slightly higher to accommodate elevated temperature drifts, which depend on the application.

#### **Reference Options**

The use of an external reference may be necessary to enhance the gain accuracy of the ADC or to improve gain matching when using multiple ADCs.

The internal reference can be enabled via the SPI, allowing the use of an external reference. See the Memory Map section for more details. The external reference is loaded by the input of an internal buffer amplifier having 3 pF of capacitance to ground. There is also a 1 k $\Omega$  internal resistor in series with the input of that buffer. The external reference must be limited to a nominal 1.25 V for an input full-scale swing of 2.5 V p-p. Additional capacitance may be necessary to keep this pin quiet depending on the external reference used.

When not using the XVREF pin, it can be tied to ground or is internally pulled to ground. However, keep this pin quiet regardless.

### Digital Outputs and Timing

The AD9467 differential outputs conform to the ANSI-644 LVDS standard on default power-up. The LVDS driver current is derived on chip and sets the output current at each output equal to a nominal 3.5 mA. A 100  $\Omega$  differential termination resistor placed at the LVDS receiver inputs results in a nominal 350 mV swing at the receiver.

The AD9467 LVDS outputs facilitate interfacing with LVDS receivers in custom ASICs and FPGAs for superior switching performance in noisy environments. Single point-to-point net topologies are recommended with a 100  $\Omega$  termination resistor placed as close to the receiver as possible. If there is no far-end receiver termination or there is poor differential trace routing, timing errors may result. To avoid such timing errors, it is recommended that the trace length be no longer than 12 inches and that the differential output traces be kept close together and at equal lengths. An example of the DCO and data with proper trace length and position is shown in Figure 20.

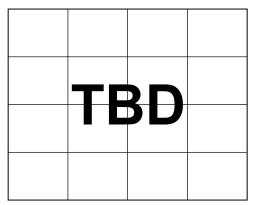


Figure 20. Output Timing Example in LVDS Mode (Default), AD9467-250

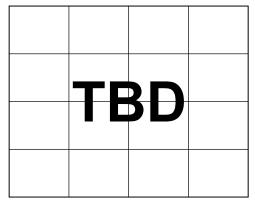


Figure 21. Output Timing Example in CMOS Mode, AD9467-250

An example of the LVDS output using the ANSI-644 standard (default) data eye and a time interval error (TIE) jitter histogram with trace lengths less than 12 inches on standard FR-4 material is shown in Figure 22. It is the responsibility of the user to determine if the waveforms meet the timing budget of the design. Additional SPI options allow the user to further increase the internal drive current of all outputs to drive longer trace lengths, thereby increasing timing margin (see Figure 22). The same can be done with shorter traces to conserve on DRVDD power consumption. Even though this produces sharper rise and fall times on the data edges and is less prone to bit errors, the power dissipation of the DRVDD supply increases or decreases depending on how this option is used.

See the Memory Map section for more details.

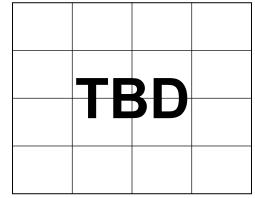


Figure 22. Data Eye for LVDS Outputs in ANSI-644 Mode with Trace Lengths Less than 12 Inches on Standard FR-4, AD9467-250

The format of the output data is offset binary by default. An example of the output coding format can be found in Table 8. To change the output data format to twos complement, see the Memory Map section.

Table 8. Digital Output Coding

Code	(VIN+) – (VIN–), Input Span = 2.5 V p-p (V)	Digital Output Offset Binary (D15:D0)
65,536	+1.25	1111 1111 1111 1111
32,768	0.00	1000 0000 0000 0000
32,767	-0.000038	0111 1111 1111 1111
0	-1.25	0000 0000 0000 0000

Two output clocks are provided to assist in capturing data from the AD9467. Data is clocked out of the AD9467 and must be captured on the rising and falling edges of the DCO that supports double data rate (DDR) capturing. See the timing diagram shown in Figure 2 for more information.

When the SPI is used, the DCO phase can be adjusted in 100pSec increments relative to the data edge. This enables the user to refine system timing margins if required. The default DCO+ and DCO- timing, as shown in Figure 2, is 90° relative to the output data edge.

There are 12 digital output test pattern options available that can be initiated through the SPI. This is a useful feature when validating receiver capture and timing. Refer to Table 10 for the output bit sequencing options available. Some test patterns have two serial sequential words and can be alternated in various ways, depending on the test pattern chosen. Note that some patterns may not adhere to the data format select option.

The PN sequence short pattern produces a pseudorandom bit sequence that repeats itself every  $2^9 - 1$  or 511 bits. A description of the PN sequence and how it is generated can be found in Section 5.1 of the ITU-T 0.150 (05/96) standard. The only difference is that the starting value must be a specific value instead of all 1s (see Table 9 for the initial values).

The PN sequence long pattern produces a pseudorandom bit sequence that repeats itself every  $2^{23}$  – 1 or 8,388,607 bits. A description of the PN sequence and how it is generated can be found in Section 5.6 of the ITU-T 0.150 (05/96) standard. The only differences are that the starting value must be a specific value instead of all 1s (see Table 9 for the initial values) and the AD9467 inverts the bit stream with relation to the ITU standard.

#### Table 9. PN Sequence

Sequence	Initial Value	First Three Output Samples (MSB First)
PN 9 Sequence, Short	0xFFFF	0x87BE, 0xAE64, 0x929D
PN 23 Sequence ,Long	0x7FFF	0x7E00, 0x807C, 0x801F

Consult the Memory Map section for information on how to change these additional digital output timing features through the SPI.

#### SPI Pins: SCLK, SDIO, CSB

For normal SPI operation, these pins should be tied to AGND through a 100 k $\Omega$  resistor on each pin. These pins are both 1.8 V and 3.3 V tolerant. However, the SDIO output logic level is dependent on the bias of the SPIVDD pin. For 3.3 V logic, tie SPIVDD to 3.3 V (AVDD2). For 1.8 V output logic, tie SPIVDD to 1.8 V (AVDD1).

The CSB pin should be tied to AVDD1 for applications that do not require SPI mode operation. By tying CSB high, all SCLK and SDIO information is ignored.

#### Table 10. Flexible Output Test Modes

Output Test Mode Bit Sequence	Pattern Name	Digital Output Word 1	Digital Output Word 2	Subject to Data Format Select
0000	Off (default)	N/A	N/A	N/A
0001	Midscale short	1000 0000 0000 0000	Same	Yes
0010	+Full-scale short	1111 1111 1111 1111	Same	Yes
0011	–Full-scale short	0000 0000 0000 0000	Same	Yes
0100	Checkerboard	1010 1010 1010 1010	0101 0101 0101 0101	No
0101	PN sequence long <sup>1</sup>	N/A	N/A	Yes
0110	PN sequence short <sup>1</sup>	N/A	N/A	Yes
0111	One-/zero-word toggle	1111 1111 1111 1111	0000 0000 0000 0000	No

<sup>1</sup> All test mode options except PN sequence short and PN sequence long can support 8- to 14-bit word lengths to verify data capture to the receiver.

### SERIAL PORT INTERFACE (SPI)

The AD9467 serial port interface allows the user to configure the converter for specific functions or operations through a structured register space provided inside the ADC. This gives the user added flexibility and customization, depending on the application. Addresses are accessed via the serial port and can be written to or read from via the port. Memory is organized into bytes that can be further divided down into fields, as detailed in the Memory Map section. Detailed operational information can be found in the AN-877 Application Note, *Interfacing to High Speed ADCs via SPI*.

There are three pins that define the SPI: SCLK, SDIO, and CSB (see Table 11). The SCLK pin is used to synchronize the read and write data presented to the ADC. The SDIO pin is a dual-purpose pin that allows data to be sent to and read from the internal ADC memory map registers. The CSB pin is an active low control that enables or disables the read and write cycles.

#### Table 11. Serial Port Pins

Pin	Function
SCLK	Serial clock. The serial shift clock input. SCLK is used to synchronize serial interface reads and writes.
SDIO	Serial data input/output. A dual-purpose pin. The typical role for this pin is an input or output, depending on the instruction sent and the relative position in the timing frame.
CSB	Chip select bar (active low). This control gates the read and write cycles.

The falling edge of the CSB in conjunction with the rising edge of the SCLK determines the start of the framing sequence. During an instruction phase, a 16-bit instruction is transmitted followed by one or more data bytes, which is determined by Bit Field W0 and Bit Field W1. An example of the serial timing and its definitions can be found in Figure 24 and Table 12. During normal operation, CSB is used to signal to the device that SPI commands are to be received and processed. When CSB is brought low, the device processes SCLK and SDIO to process instructions. Normally, CSB remains low until the communication cycle is complete. However, if connected to a slow device, CSB can be brought high between bytes, allowing older microcontrollers enough time to transfer data into shift registers. CSB can be stalled when transferring one, two, or three bytes of data. When W0 and W1 are set to 11, the device enters streaming mode and continues to process data, either reading or writing, until CSB is taken high to end the communication cycle. This allows complete memory transfers without requiring additional instructions. Regardless of the mode, if CSB is taken high in the middle of a byte transfer, the SPI state machine is reset and the device waits for a new instruction.

In addition to the operation modes, the SPI port configuration influences how the AD9467 operates. When operating in 2-wire mode, it is recommended to use a 1-, 2-, or 3-byte transfer exclusively. Without an active CSB line, streaming mode can be entered but not exited.

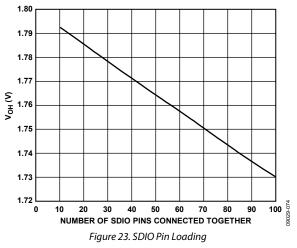
In addition to word length, the instruction phase determines if the serial frame is a read or write operation, allowing the serial port to be used to both program the chip and read the contents of the on-chip memory. If the instruction is a readback operation, performing a readback causes the SDIO pin to change from an input to an output at the appropriate point in the serial frame.

Data can be sent in MSB- or LSB-first mode. MSB-first mode is the default at power-up and can be changed by adjusting the configuration register. For more information about this and other features, see the AN-877 Application Note, *Interfacing to High Speed ADCs via SPI*.

### HARDWARE INTERFACE

The pins described in Table 11 compose the physical interface between the programming device of the user and the serial port of the AD9467. The SCLK and CSB pins function as inputs when using the SPI. The SDIO pin is bidirectional, functioning as an input during write phases and as an output during readback.

If multiple SDIO pins share a common connection, care should be taken to ensure that proper  $V_{\rm OH}$  levels are met. Assuming the same load for each AD9467, Figure 23 shows the number of SDIO pins that can be connected together and the resulting  $V_{\rm OH}$  level.



This interface is flexible enough to be controlled by either serial PROMS or PIC mirocontrollers, providing the user with an alternative method, other than a full SPI controller, to program the ADC (see the AN-812 Application Note).

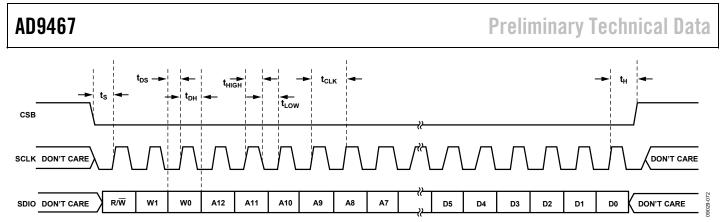


Figure 24. Serial Timing Details

### Table 12. Serial Timing Definitions

Parameter	Timing (Minimum, ns)	Description
t <sub>Ds</sub>	5	Setup time between the data and the rising edge of SCLK
t <sub>DH</sub>	2	Hold time between the data and the rising edge of SCLK
<b>t</b> clk	40	Period of the clock
ts	5	Setup time between CSB and SCLK
tн	2	Hold time between CSB and SCLK
tніgн	16	Minimum period that SCLK should be in a logic high state
tLOW	16	Minimum period that SCLK should be in a logic low state
t <sub>en_sdio</sub>	10	Minimum time for the SDIO pin to switch from an input to an output relative to the SCLK falling edge (not shown in Figure 24)
t <sub>dis_sdio</sub>	10	Minimum time for the SDIO pin to switch from an output to an input relative to the SCLK rising edge (not shown in Figure 24)

### MEMORY MAP reading the memory map table

Each row in the memory map register table (see Table 13) has eight address locations. The memory map is divided into three sections: the chip configuration register map (Address 0x00 to Address 0x02), the device index and transfer register map (Address 0xFF), and the ADC functions register map (Address 0x08 to Address 0x107).

The leftmost column of the memory map indicates the register address number, and the default value is shown in the second rightmost column. The (MSB) Bit 7 column is the start of the default hexadecimal value given. For example, Address 0x09, the clock register, has a default value of 0x01, meaning Bit 7 = 0, Bit 6 = 0, Bit 5 = 0, Bit 4 = 0, Bit 3 = 0, Bit 2 = 0, Bit 1 = 0, and Bit 0 = 1, or 0000 0001 in binary. This setting is the default for the duty cycle stabilizer in the on condition. By writing a 0 to Bit 0 of this address, the duty cycle stabilizer turns off. For more information on this and other functions, consult the AN-877 Application Note, *Interfacing to High Speed ADCs via SPI*.

### **RESERVED LOCATIONS**

Undefined memory locations should not be written to except when writing the default values suggested in this data sheet. Addresses that have values marked as 0 should be considered reserved and have a 0 written into their registers during power-up.

### **DEFAULT VALUES**

When the AD9467 comes out of a reset, critical registers are preloaded with default values. These values are indicated in Table 13, where an X refers to an undefined feature.

### LOGIC LEVELS

An explanation of various registers follows: "Bit is set" is synonymous with "bit is set to Logic 1" or "writing Logic 1 for the bit." Similarly, "clear a bit" is synonymous with "bit is set to Logic 0" or "writing Logic 0 for the bit."

Table 13. Memory Map Register<sup>1</sup>

Addr. (Hex)	Parameter Name	(MSB) Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	(LSB) Bit 0	Default Value (Hex)	Default Notes/ Comments
Chip Co	onfiguration Registe	er					1				
00	chip_port_config	X	LSB first 1 = on 0 = off (default)	Soft reset 1 = on 0 = off (default)	1	1	X	X	X	0x18	The nibbles should be mirrored so that LSB- or MSB-first mode is set correctly regard- less of shift mode.
01	chip_id		8-bit Chip ID Bits[7:0] (AD9467 = 0x50, default)							Read only	Default is unique chip ID, different for each device. This is a read- only register.
02	chip_grade	x		Child ID [6: device varian 001 = 200 M 010 = 250 M	ts of chip ID) SPS	X	X	x	x	Read only	Child ID used to differentiate graded devices.
Device	Index and Transfer	Register									
FF	device_update	x	x	x	X	x	x	x	SW transfer 1 = on 0 = off (default)	0x00	Synchronously transfers data from the master shift register to the slave.
ADC Fu	inctions				-					-	
08	modes	X	x	x	X	x	X	Internal power- down mode 00 = chip run (default) 01 = full power- down		0x00	Determines various generic modes of chip operation.
09	clock	x	x	x	X	x	x	x	Duty cycle stabilizer 1 = on (default) 0 = off	0x01	Turns the internal duty cycle stabilizer on and off.
0D	test_io	X	x	Reset PN long gen 1 = on 0 = off (default)	Reset PN short gen 1 = on 0 = off (default)	010 010	mode—see Ta tiputs and Timi 0000 = off (d 0001 = midsca 0010 = +FS 0011 = -FS 00 = checkerbo 0101 = PN 23 so 0110 = PN 9 see 1 = one-/zero-v	0x00	When this register is set, the test data is placed on the output pins in place of normal data.		
OF	adc_input	XVREF 1 = on 0 = off (default)	X	X	X	X	Analog disconnect 1 = on 0 = off (default)	X	X	0x00	Analog input functions
10	offset	8-bit digital offset adjustment           0000 0000           0000 0001           0000 0010           0000 0011              1111 1111								0x00	Digital offset adjustment in LSBs.

## AD9467

Addr. (Hex)	Parameter Name	(MSB) Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	(LSB) Bit 0	Default Value (Hex)	Default Notes/ Comments
14	output_mode	X	0	X	Digital output disable 1 = on 0 = off (default)	1	Output invert 1 = on 0 = off (default)	Dat 9 00 binar 01 com	a format select = offset y (default) = twos oplement Gray code	0x08	Configures the outputs and the format of the data.
15	output_adjust	X	X	X	X	Coarse         Output current drive adjust           LVDS         000 = coarse adjust enabled           adjust         001 = 3.5 mA           0 =         010 = 3.25 mA           3.5 mA         011 = 3.0 mA           (default)         100 = 2.75 mA           1 =         101 = 2.5 mA           2.0 mA         110 = 2.25 mA           111 = 2.0 mA         111 = 2.0 mA			0x00	Determines LVDS or other output properties.	
16	output_phase	DCO output invert 1 = on 0 = off (default)	x	x	x	x	x	X	X	0x00	Determines digital clock output phase.
17	output_delay	DCO delay enable 1 = on 0 = off (default)	x	x	5-b	5-bit digital clock output delay adjustment 0 0000 0 0001 0 0010 0 0011  1 1111					Determines digital clock output delay.
18	vref	X	X	X	X						
2C	analog_input	x	x	x	X	X	Input coupling mode 0 = ac coupling (default) 1 = dc coupling	X	x	0x00	Determines the input coupling mode.
36	Buffer Current Select 1		110101 = +530% $110100 = +520%$ $$ $000010 = +20%$ $000001 = +10%$ $000000 = Nominal (Default)$ $111111 = -10%$ $111110 = -20%$ $$ $110111 = -90%$ $110110 = -100%$							0x02	Determines the internal buffer current setting.
107	Buffer Current Select 2	110110 = -100%     X     X       110101 = +530%     X     X       110100 = +520%         000010 = +20%     000001 = +10%        000000 = Nominal (Default)     111111 = -10%								0x03	Determines the internal buffer current setting.

Addr. (Hex)	Parameter Name	(MSB) Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	(LSB) Bit 0	Default Value (Hex)	Default Notes/ Comments
				111	1110 = -20%						
				110	0111 = -90%						
				110	110 = -100%						

 $^{1}$  X = don't care.

AD9467

# AD9467

### Power and Ground Recommendations

When connecting power to the AD9467, it is recommended that three separate supplies be used: one for analog AVDD1 (1.8 V), one for analog AVDD2 (3.3 V) and one for digital output drivers DRVDD (1.8 V). If only one supply is available, it should be routed to the AVDD1 first and then tapped off and isolated with a ferrite bead or a filter choke preceded by decoupling capacitors for the DRVDD. The user can employ several different decoupling capacitors to cover both high and low frequencies. These should be located close to the point of entry at the PC board level and close to the parts, with minimal trace lengths.

A single PC board ground plane should be sufficient when using the AD9467. With proper decoupling and smart partitioning of the PC board's analog, digital, and clock sections, optimum performance can be easily achieved.

### Exposed Paddle Thermal Heat Slug Recommendations

It is required that the exposed paddle on the underside of the ADC be connected to analog ground (AGND) to achieve the best electrical and thermal performance of the AD9467. An exposed continuous copper plane on the PCB should be connected to the AD9467 exposed paddle, Pin 0. The copper plane should have several vias to achieve the lowest possible resistive thermal path for heat dissipation to flow through the bottom of the PCB. These vias should be solder-filled or plugged.

To maximize the coverage and adhesion between the ADC and PCB, partition the continuous copper plane by overlaying a silkscreen on the PCB into several uniform sections. This provides several tie points between the ADC and PCB during the reflow process, whereas using one continuous plane with no partitions only guarantees one tie point. See Figure 25 for a PCB layout example. For detailed information on packaging and the PCB layout of chip scale packages, see the AN-772 Application Note, *A Design and Manufacturing Guide for the Lead Frame Chip Scale Package (LFCSP)*.

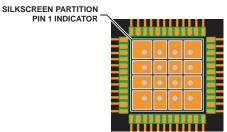


Figure 25. Typical PCB Layout

#### **OUTLINE DIMENSIONS** 0.60 \_ 10.00 BSC SQ 0.42 0.60 0.24 0.42 PIN 1 INDICATOR 7 0.24 50000000000000000000000000072 T -⊕-PIN 1 INDICATOR 0.50 BSC 9.75 BSC SQ EXPOSED PAD (BOTTOM VIEW) 7 8.60 8.50 SQ Ā 8.40 0.50 0.40 0.30 <u> ซ์ถูกกกกกกกกกกกกฏฐ</u> ● 0.20 MIN TOP VIEW A 8.50 REF 0.70 12° MAX 0.65 0.90 0.60 FOR PROPER CONNECTION OF THE EXPOSED PAD, REFER TO THE PIN CONFIGURATION AND FUNCTION DESCRIPTIONS SECTION OF THIS DATA SHEET. 0.85 0.05 MAX Π 0.80 <u>t t</u> 0.01 NOM COPLANARITY 4 0.30 SEATING 0.20 REF 0.08 PLANE - 0.23 0.18 121809-B COMPLIANT TO JEDEC STANDARDS MO-220-VNND-4 Figure 26. 72-Lead Lead Frame Chip Scale Package, Exposed Pad [LFCSP\_VQ] 10 mm × 10 mm Body, Very Thin Quad (CP-72-5) Dimensions shown in millimeters

#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
AD9467BCPZ-250	-40°C to +85°C	72-Lead LFCSP_VQ	CP-72-5
AD9467BCPZ-200	-40°C to +85°C	72-Lead LFCSP_VQ	CP-72-5
AD9467-200EBZ		AD9467-200 Evaluation Board	
AD9467-250EBZ		AD9467-250 Evaluation Board	

 $^{1}$  Z = RoHS Compliant Part.

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